

UPDATED 07/12/2007

### 14.00-14.50 GHz 8-Watt Internally-Matched Power FET

### **FEATURES**

- 14.00-14.50 GHz Bandwidth
- Input/Output Impedance Matched to 50 Ohms
- +39.5 dBm Output Power at 1dB Compression
- 6.5 dB Power Gain at 1dB Compression
- 27% Power Added Efficiency
- **Hermetic Metal Flange Package**
- 100% Tested for DC, RF, and  $R_{TH}$



The EID1414A1-8 is a high power, highly linear, single stage MFET amplifier in a flange mount package. This amplifier features Excelics' unique PHEMT transistor technology.





### **ELECTRICAL CHARACTERISTICS (Ta = 25°C)**

SYMBOL	PARAMETERS/TEST CONDITIONS <sup>1</sup>	MIN	TYP	MAX	UNITS
P <sub>1dB</sub>	Output Power at 1dB Compression f = 14.00-14.50GHz $V_{DS}$ = 10 V, $I_{DSQ} \approx 2200$ mA	38.5	39.5		dBm
G <sub>1dB</sub>	Gain at 1dB Compression $V_{DS} = 10 \text{ V}$ , $I_{DSQ} \approx 2200 \text{mA}$ $f = 14.00-14.50 \text{GHz}$	5.5	6.5		dB
ΔG	Gain Flatness $f = 14.00-14.50GHz$ $V_{DS} = 10 \text{ V}, I_{DSQ} \approx 2200\text{mA}$			±0.6	dB
PAE	Power Added Efficiency at 1dB Compression $V_{DS} = 10 \text{ V}, I_{DSQ} \approx 2200 \text{mA}$ f = 14.00-14.50GHz		27		%
Id <sub>1dB</sub>	Drain Current at 1dB Compression f = 14.00-14.50GHz		2800	3600	mA
I <sub>DSS</sub>	Saturated Drain Current $V_{DS} = 3 \text{ V}, V_{GS} = 0 \text{ V}$		4200	5760	mA
V <sub>P</sub>	Pinch-off Voltage $V_{DS} = 3 \text{ V}, I_{DS} = 40 \text{ mA}$		-1.2	-2.5	V
R <sub>TH</sub>	Thermal Resistance <sup>2</sup>		3.5	4.0	°C/W

#### Notes:

- Tested with 100 Ohm gate resistor.
- Overall Rth depends on case mounting.



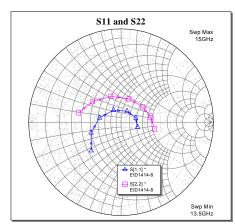
# **UPDATED 07/12/2007** 14.00-14.50 GHz 8-Watt Internally-Matched Power FET ABSOLUTE MAXIMUM RATINGS FOR CONTINUOUS OPERATION<sup>1,2</sup>

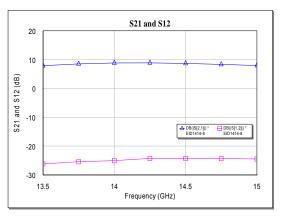
SYMBOL	CHARACTERISTIC	VALUE		
$V_{DS}$	Drain to Source Voltage	10 V		
$V_{GS}$	Gate to Source Voltage	-4.5 V		
I <sub>DS</sub>	Drain Current	IDSS		
$I_{GSF}$	Forward Gate Current	80 mA		
P <sub>IN</sub>	Input Power	@ 3dB compression		
$P_T$	Total Power Dissipation	35 W		
$T_CH$	Channel Temperature	150°C		
$T_{STG}$	Storage Temperature	-65/+150°C		

- Operating the device beyond any of the above ratings may result in permanent damage or reduction of MTTF. Bias conditions must also satisfy the following equation  $P_T < (T_{CH} T_{PKG})/R_{TH}$ ; where  $T_{PKG} = T_{PKG} + T_{PKG}$  and  $P_T = (V_{DS} * I_{DS}) - (P_{OUT} - P_{IN}).$

### PERFORMANCE DATA

Typical S-Parameters (T= 25°C, 50Ω system, de-embedded to edge of package)  $V_{DS} = 10 \text{ V}, I_{DSO} \approx 2200 \text{mA}$ 





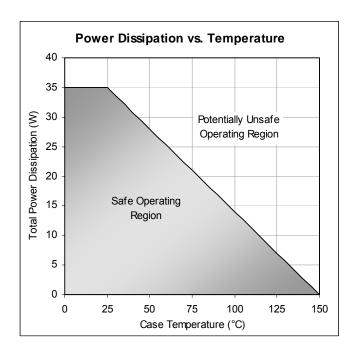
FREQ	S	11	S	21	S	12	S	22
(GHz)	MAG	ANG	MAG	ANG	MAG	ANG	MAG	ANG
13.60	0.4077	-145.55	2.5516	132.84	0.0504	118.29	0.4354	159.24
13.70	0.3666	-155.39	2.6444	123.30	0.0528	105.14	0.3997	149.67
13.80	0.3254	-166.06	2.6910	114.68	0.0542	97.21	0.3624	138.73
13.90	0.2798	-178.28	2.7499	104.97	0.0560	87.14	0.3259	126.21
14.00	0.2373	168.69	2.7742	95.48	0.0561	76.29	0.2990	111.82
14.10	0.1971	152.39	2.7890	86.00	0.0580	65.56	0.2760	96.10
14.20	0.1656	132.83	2.7922	76.30	0.0610	55.52	0.2647	80.39
14.30	0.1424	109.53	2.7801	66.44	0.0601	46.74	0.2660	63.22
14.40	0.1325	86.10	2.7470	57.12	0.0615	37.32	0.2747	48.13
14.50	0.1346	61.35	2.7206	47.94	0.0610	27.10	0.2865	35.06
14.60	0.1456	41.09	2.6903	38.72	0.0610	15.70	0.3018	23.52
14.70	0.1612	23.89	2.6450	29.91	0.0606	5.80	0.3201	13.11
14.80	0.1724	9.26	2.5955	20.97	0.0602	-2.53	0.3389	4.09
14.90	0.1832	-3.80	2.5416	12.02	0.0587	-14.26	0.3527	-4.26



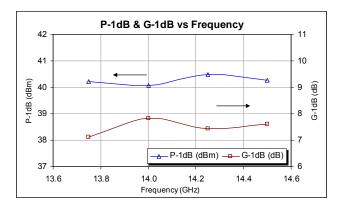
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### **Power De-rating Curve**



### Typical Power Data ( $V_{DS} = 10 \text{ V}$ , $I_{DSQ} = 2200 \text{ mA}$ )



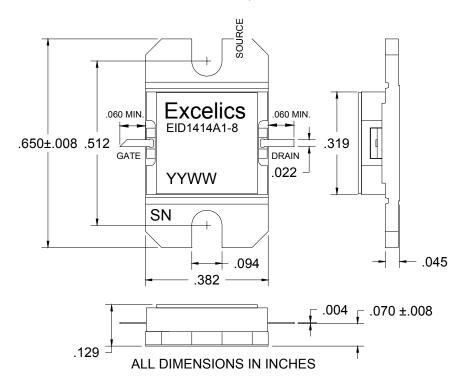


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### **PACKAGE OUTLINE**

Dimensions in inches, Tolerance ± .005 unless otherwise specified



### **ORDERING INFORMATION**

Part Number	Grade <sup>1</sup>	f <sub>Test</sub> (GHz)	P <sub>1dB</sub> (min)
EID1414A1-8	Industrial	14.00-14.50 GHz	38.5

Notes:

- 1. Contact factory for military and hi-rel grades.
- 2. Exact test conditions are specified in "Electrical Characteristics" table.

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